

attach to #5

B/O Form PTO-1449	Applicant JEK/BEU/OLAFSSON	Serial Number 09/670,028
U.S. Department of Commerce Patent and Trademark Office	Applicant Greinn OLAFSSON	
Information Disclosure Statement by Applicant	Filing Date September 26, 2000	Group 1762

OFFICE
JAN 31 2002
PATENT & TRADEMARK OFFICE

U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
[Signature]	4566937	1/86	Pitts			
	5534311	7/96	Shaw et al			
	6261421	7/01	Meunier et al			
	5509843	4/96	Akama			
	5352330	10/94	Wallace			
	5015323	5/91	Gallagher			
	5038322	8/91	Van Loenen			
	4343993	8/82	Binnig et al			
[Signature]	5043578	8/91	Guethner et al			
	4896044	1/90	Li et al			
	5047649	9/91	Hodgson et al			

RECEIVED
FEB 14 2002
T/C 1762

Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
						Yes	No

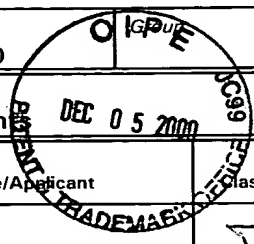
Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)

Examiner <i>[Signature]</i>	Date Considered <i>9/16/02</i>
--------------------------------	-----------------------------------

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

attach to #4

B/O Form PTO-1449 U.S. Department of Commerce Patent and Trademark Office Information Disclosure Statement by Applicant	Atty. Docket Number JEK/BEU/OLAFSSON	Serial Number 09/670,028
	Applicant Sveinn OLAFSSON	
	Filing Date September 26, 2000	1762



U.S. Patent Documents

Examiner Initial	Document Number	Date	Patentee/Applicant	Class	Subclass	Filing Date if Appropriate
MJP	3,663,788	05/1972	INOUE			
	3,713,213	01/1973	CRANSTON			
	3,720,598	03/1973	THOMPSON			
	3,778,893	12/1973	THOMPSON			
	3,805,120	04/1974	CRANSTON			
	4,131,524	12/1978	GIELES			
	4,520,252	05/1985	INOUE			
	4,731,515	03/1988	SAVAGE et al.			
	5,648,128	07/1997	YEH et al.			
	5,728,261	03/1998	WOLFE et al.			
MJP	5,837,332	11/1998	TAKAHASHI et al.			
	6,001,426	12/1999	WITHERSPOON et al.			

Foreign Patent Documents

Examiner Initial	Document Number	Publication Date	Country/Agency	Class	Subclass	Translation	
						Yes	No

Other Documents (Including Author, Title, Date, Pertinent Pages, Place of Publication, Etc.)

MJP	Marchand, H., et al., <u>Structural and optical properties of GaN laterally overgrown on Si(111) by metalorganic chemical vapor deposition using an AlN buffer layer</u> , pp. 1-10, MRS Internet J. Nitride Semicond. Res. 4, 2 (1999). <i>(no month given, but after March 10th)</i>
MJP	Van der Stricht, W., et al., <u>Study of GaN films grown by metalorganic chemical vapour deposition</u> , pp. 1-6, MRS Internet J. Nitride Semicond. Res. Vol. 1, Art. 3 (1996). <i>(month not given, but after Aug 5th)</i>
MJP	Marchand, H., et al., <u>Fast Lateral Epitaxial Overgrowth of Gallium Nitride by Metalorganic Chemical Vapor Deposition Using a Two-Step Process</u> , pp. 1-6, MRS Internet J. Nitride Semicond. Res. 4S1, G4.5 (1999). <i>no month</i>
MJP	Runge, Keith, et al., <u>Shock and Pressure Wave Propagation in Nano-fluidic Systems</u> , Abstract, Sixth Foresight Conference on Molecular Nanotechnology (1998). <i>no month</i>

Examiner <i>Michael Padgett</i>	Date Considered <i>9/16/02</i>
------------------------------------	-----------------------------------

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with MPEP 609; Draw a line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.